## Notice of References Cited Application/Control No. 10/624,511 Examiner FEBEN HAILE Applicant(s)/Patent Under Reexamination CEREDA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-4,792,771	12-1988	Siu, David	333/208	
	В	US-				
	O	US-				
	D	US-				
	Е	US-				
	F	US-				
	G	US-				
	Ι	US-				
	_	US-				
	J	US-				
	K	US-				
	L	US-				
	М	US-				

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
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## NON-PATENT DOCUMENTS

	NON I ALENT DOCUMENTO					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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